PATENT COOPERATION TREATY

PCT

INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY (Chapter II of the Patent Cooperation Treaty)

(PCT Article 36 and Rule 70)

		ent's file reference. -PCT	ce i	FOR FURTHER A	CTION	See Form PCT/IPEA/416				
Internati	onal app	olication No.		International filing da	te (day/month/year)	Priority date (day/month/year)				
PCT/JP2004/009911			911	12.07.200	4	16.07.2003				
International Patent Classification (IPC) or national classification and IPC										
G01N13/16, G12B21/08										
Applicant JAPAN SCIENCE AND TECHNOLOGY AGENCY ET AL										
1.	 This report is the international preliminary examination report, established by this International Preliminary Examining Authority under Article 35 and transmitted to the applicant according to Article 36. 									
2.	This R	EPORT consists	of a total of	5	sheets, including	g this cover sheet.				
3.	This re	port is also accor	mpanied by Al	NNEXES, comprising:						
	a. 🗵	(sent to the d	applicant and	to the International Bu	reau) a total of	sheets, as follows:				
	sheets of the description, claims and/or drawings which have been amended and are the basis for this report and/or sheets containing rectifications authorized by this Authority (see Rule 70.16 and Section 607 of the Administrative Instructions).									
	sheets which supersede earlier sheets, but which this Authority considers contain an amendment that goes beyond the disclosure in the international application as filed, as indicated in item 4 of Box No. I and the Supplemental Box.									
	ь. Г	٦	International L	Bureau only) a total of	(indicate type and numbe	r of electronic carrier(s))				
	, containing a sequence listing and/or tables related thereto, in computer readable form only, as indicated in the Supplemental Box Relating to Sequence Listing (see Section 802 of the Administrative Instructions).									
4.	This re	port contains ind	ications relatir	ng to the following iter	ns:					
	\boxtimes	Box No. I	Basis of the	report						
		Box No. II	Priority							
		Box No. III	Non-establis	shment of opinion with	regard to novelty, invent	ive step and industrial applicability				
		Box No. IV	Lack of unit	y of invention						
	Box No. V Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement									
		Box No. VI	Certain docu	uments cited						
		Box No. VII	Certain defe	cts in the international	application					
	Box No. VIII Certain observations on the international application									
Date of submission of the demand				Date of completion of th	is report					
Name and mailing address of the IPEA/JP					Authorized officer					
Feesimile No.					Telephone No					

Translation

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INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY

International application No.
PCT/JP2004/009911

Box	No. I	Basis of the report						
1.		d to the language, this report is based on the internation	onal application in the language in	which it was filed, unless otherwise				
	This report is based on translations from the original language into the following language which is the language of a translation furnished for the purposes of: international search (Rule 12.3 and 23.1(b))							
		publication of the international application (Rule 12.4	l)					
		international preliminary examination (Rule 55.2 and						
2.	this report)	d to the elements of the international application, this Office in response to an invitation under Article 14 at 15: Iternational application as originally filed/furnished escription:	report is based on (replacement s re referred to in this report as "o	sheets which have been furnished to the riginally filed" and are not annexed to				
	page	s <u>1-11</u>		as originally filed/furnished				
	page	s*	received by this Authority on					
	page	s*	received by this Authority on					
	the c	laims:						
	nos.	2,4-7		as originally filed/furnished				
	nos.*		as amended (togethe	er with any statement) under Article 19				
	nos.*	1	received by this Authority on	30.03.2005				
	nos.*							
	the d	trawings:	-					
	sheet			as originally filed/furnished				
	sheet			as siighen, mas reminis				
	sheet	<u> </u>	received by this Authority on					
			_	****				
1	□ a seq	puence listing and/or any related table(s) – see Supplen	nental Box Relating to Sequence I	asung.				
3.	The	amendments have resulted in the cancellation of:						
		the description, pages						
	\square	the claims, nos. 3						
		the drawings, sheets/figs	<u> </u>					
		the sequence listing (specify):						
		any table(s) related to sequence listing (specify):						
4.	This they	report has been established as if (some of) the amen have been considered to go beyond the disclosure as f	dments annexed to this report and iled, as indicated in the Suppleme	d listed below had not been made, since ntal Box (Rule 70.2(c)).				
ŀ		the description, pages						
ŀ		the claims, nos.						
		the drawings, sheets/figs						
		the sequence listing (specify):						
		any table(s) related to sequence listing (specify):						
	lf item 4 a	pplies, some or all of those sheets may be marked "sup	perseded."					

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Box		Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement				
1.	Statement					
	Novelty (N)	Claims	1, 2, 4-7	YES		
		Claims		NO		
	Inventive step (IS)	Claims		YES		
		Claims	1, 2, 4-7	NO		
	Industrial applicability (IA)	Claims	1, 2, 4-7	YES		
		Claims		NO		

- 2. Citations and explanations (Rule 70.7)
 - Document 1: JP 8-320326 A (Nikon Corp.), 3 December 1996; entire text and all drawings
 - Document 2: JP 10-307144 A (Olympus Corp.), 17 November 1998; entire text and all drawings
 - Document 5: JP 2000-168755 A (Tokyo Seimitsu Co., Ltd.), 14 June 2002; paragraph [0017] and fig. 6
 - Document 6: JP 2000-206126 A (Hitachi, Ltd.), 28 July 2000; paragraph [0013] and fig. 3

Document 1 (see, for example, Fig. 2), discloses a scanning probe microscope probe which is equipped with a probe base part, and a supporting cantilever extending horizontally from the base part, and a measuring cantilever at the end of the supporting cantilever.

Document 2 discloses a scanning probe microscope probe which is equipped with a probe base part (second support part (26)), and a supporting member (first supporting member (24)), and a measuring cantilever at the end of the supporting member (cantilever (20)).

Document 2 also discloses features such as single silicon crystal and joining; it also discloses features relating to the cantilever, such as a length of 50 micrometers and a thickness of 1 micrometer or less and making

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Box No. V Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement

it short in length and thin in width, and precisely stipulating the length, and discloses features relating to the supporting member such engineering to give it an inclined surface.

Newly cited document 5 discloses a scanning probe microscope probe which is equipped with a probe base part (the thick portion of the cantilever holder (7)), and a supporting member (the thin portion close to the end of the cantilever holder (7)), and a measuring cantilever at the end of the supporting member (cantilever (6)), and the end of the aforementioned supporting member is engineered to give an inclined surface.

In addition, cantilevers with a length of 20 micrometers or less are well known in the art, as disclosed in newly cited document 6.

Since the invention disclosed in document 1 and the inventions disclosed in documents 2, 5 and 6 relate to a common field of scanning probe microscopes, application of the art disclosed in documents 2, 5 and 6 in a scanning probe microscope probe disclosed in document 1 to constitute the inventions set forth in claims 1, 2 and 5 is obvious to a person skilled in the art.

Claim 4

Document 1:

Document 2:

Document 3: JP 10-311843 A (Nikon Corp.), 24 November 1998; entire text and all drawings

Document 5:

Document 6:

Document 3 discloses a scanning probe microscope

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Box No. V Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement

probe, and discloses features such as making the cantilever thin

Stipulating the length disclosed in document 2 for the thin part of the cantilever disclosed in document 3 is obvious to a person skilled in the art.

Claims 6 and 7

Document 1:

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Document 2:

Document 4: JP 2002-5810 A (Canon Corp.), 9 January

2002; entire text and all drawings

Document 5:

Document 6:

Document 4 discloses a process for fabricating a scanning probe microscope probe, and discloses features such as joining the SOI substrate, removing the handle wafer and buried oxide film, and wet etching.